



# Fast switching diode

## Features

1. High reliability
2. High conductance
3. Fast switching speed ( $t_{rr} \leq 4 \text{ ns}$ )



## Applications

For general purpose switching applications

## Construction

Silicon epitaxial planar

## Absolute Maximum Ratings

$T_j = 25^\circ\text{C}$

Parameter	Test Conditions	Symbol	Value	Unit
Non repetitive peak reverse voltage		$V_{RM}$	100	V
Repetitive peak reverse voltage		$V_{RRM}$	75	V
Working peak reverse voltage		$V_{RWM}$	75	V
DC blocking voltage		$V_R$	75	V
RMS reverse voltage		$V_{R(RMS)}$	53	V
Forward current		$I_F$	300	mA
Average rectified current	Half wave rectification with resistive load and $f > 50\text{MHz}$	$I_{FAV}$	200	mA
Non repetitive peak forward surge current	$t = 1\text{s}$	$I_{FSM}$	1	A
	$t = 1\mu\text{s}$	$I_{FSM}$	4	A
Power dissipation	$I = 4\text{mm}$ $T_L = 25^\circ\text{C}$	$P_d$	500	mW
Storage temperature range		$T_{stg}$	-65~+175	°C

Stresses exceeding maximum ratings may damage the device. Maximum ratings are stress ratings only. Functional operation above the recommended operating conditions is not implied. Extended exposure to stresses above the recommended operating conditions may affect device reliability.

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## Electrical Characteristics

$T_j=25^\circ\text{C}$

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
Forward voltage	$I_F=10\text{mA}$	$V_F$			1	V
Peak reverse current	$V_R=20\text{V}$	$I_R$			25	nA
	$V_R=20\text{V}, T_j=150^\circ\text{C}$	$I_R$			50	$\mu\text{A}$
	$V_R=75\text{V}$	$I_R$			5	$\mu\text{A}$
Breakdown voltage	$I_R=100\mu\text{A}$	$V_R$	100			V
Diode capacitance	$V_R=0, f=1\text{MHz}$	$C_D$			4	pF
Reverse recovery time	$I_F=10\text{mA}$ to $I_R=1\text{mA}$ , $V_R=6\text{V}$ , $R_L=100\Omega$	$t_{rr}$			4	ns

## Characteristics ( $T_j=25^\circ\text{C}$ unless otherwise specified)

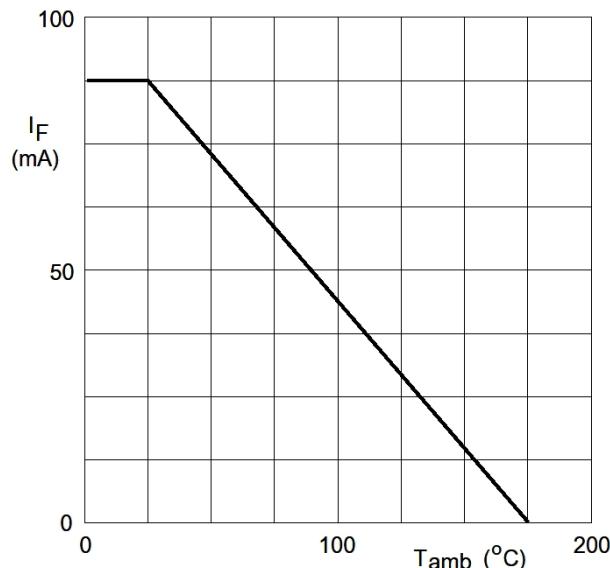


Figure 1. Maximum permissible continuous forward current vs. ambient temperature

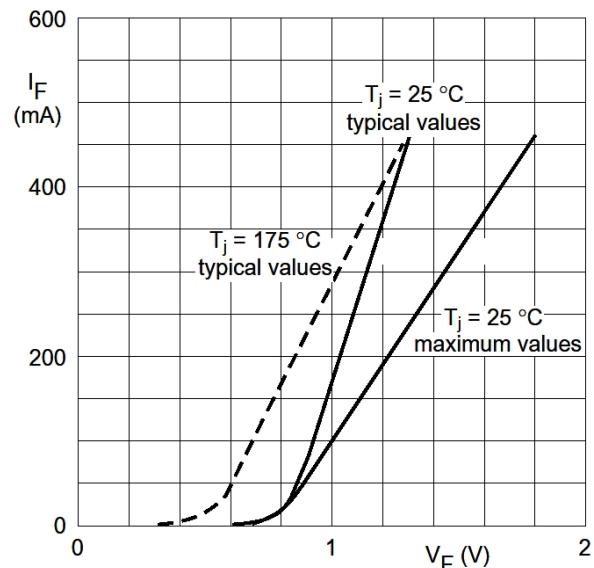


Figure 2. Forward current vs. forward voltage

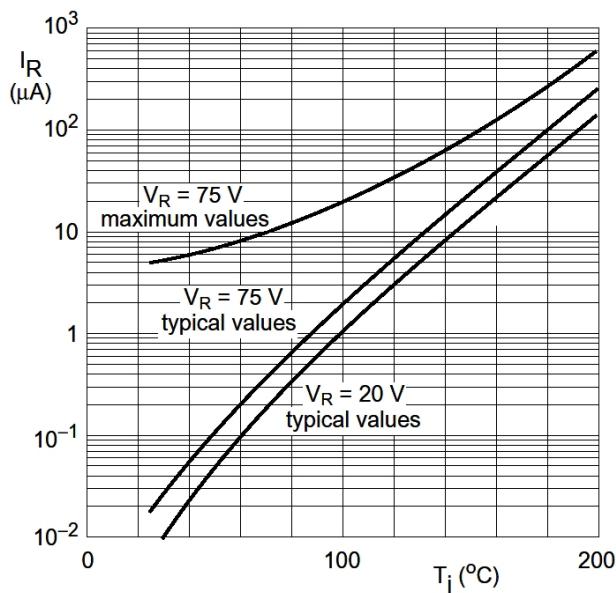
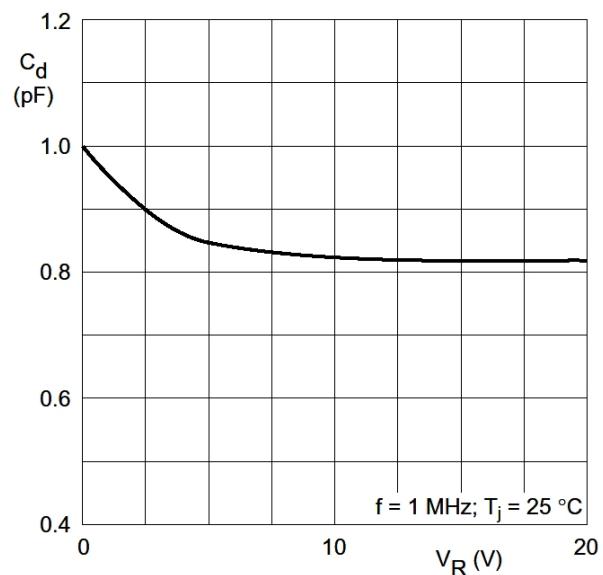
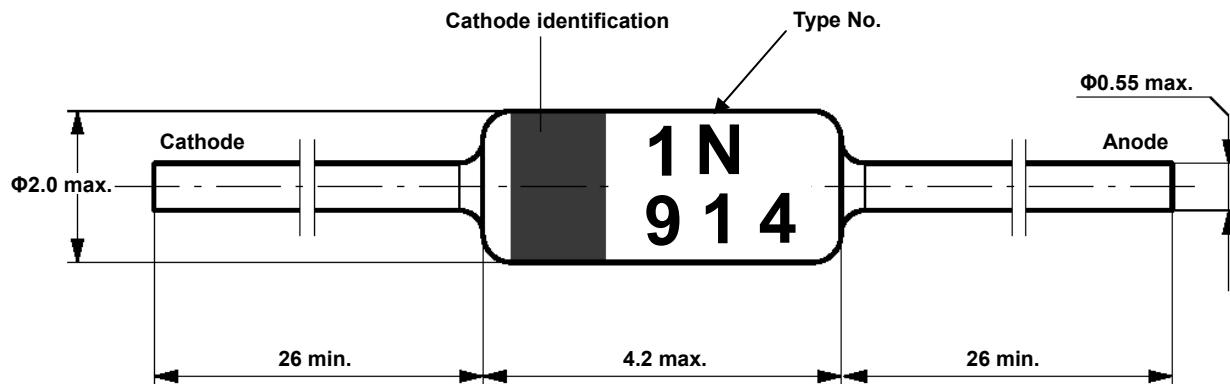


Figure 3. Reverse current vs. junction temperature

Figure 4. Diode capacitance vs. reverse voltage  
(Typical values)

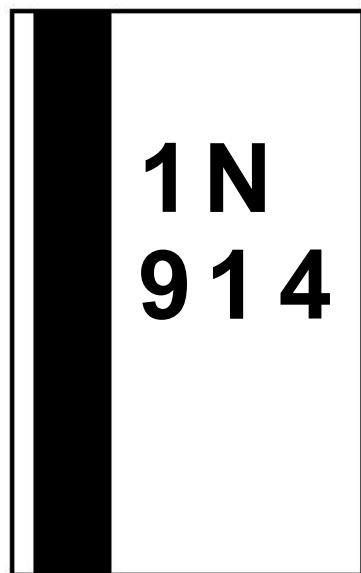


## Dimensions in mm



Standard Glass Case  
JEDEC DO-35

## Marking



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